

STW47NM60ND

Automotive-grade N-channel 600 V, 0.075 Ω typ., 35 A FDmesh™ II Power MOSFET (with fast diode) in a TO-247 package

Datasheet - production data

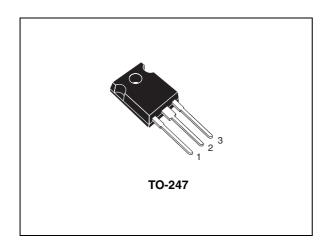
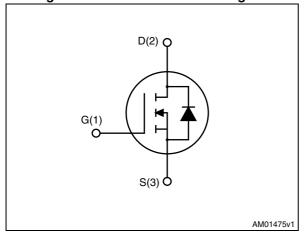


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} @ T _{JMAX}	R _{DS(on)} max	I _D
STW47NM60ND	650 V	$0.088~\Omega$	35 A

- Designed for automotive applications and AEC-Q101 qualified
- The worldwide best R_{DS(on)}*area amongst the fast recovery diode devices
- 100% avalanche tested
- · Low input capacitance and gate charge
- Low gate input resistance
- Extremely high dv/dt and avalanche capabilities.

Applications

· Switching applications

Description

This device is an N-channel Power MOSFET developed using the second generation of MDmesh™ technology. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order code	Marking Packages		Packaging	
STW47NM60ND	47NM60ND	TO-247	Tube	

Contents STW47NM60ND

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STW47NM60ND Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	± 25	V
I _D	Drain current (continuous) at T _C = 25 °C	35	Α
I _D	Drain current (continuous) at T _C = 100 °C	22	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	140	Α
P _{TOT}	Total dissipation at T _C = 25 °C	255	W
dv/dt (2)	Peak diode recovery voltage slope	40	V/ns
T _{stg}	Storage temperature	-55 to 150	°C
T _j	Max. operating junction temperature	150	°C

^{1.} Pulse width limited by safe operating area

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	0.49	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	50	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_{j Max}$)	14	А
E _{AS}	Single pulse avalanche energy (starting T _J =25 °C, I _D =I _{AS} , V _{DD} =50 V)	1000	mJ

^{2.} $I_{SD} \leq 35$ A, di/dt ≤ 600 A/ μ s, $V_{DD} = 80\%$ $V_{(BR)DSS}$

Electrical characteristics STW47NM60ND

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified).

Table 5. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
1	Zero gate voltage	V _{DS} = 600 V			10	μΑ
I _{DSS}	drain current (V _{GS} = 0)	V _{DS} = 600 V, T _j = 125 °C			100	μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 20 V			±100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 17.5 A		0.075	0.088	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 _{fs} ⁽¹⁾	Forward transconductance	V _{DS} =15 V _, I _D = 17.5 A	-	17	-	S
C _{iss}	Input capacitance		-	4200	-	pF
C _{oss}	Output capacitance	$V_{DS} = 50 \text{ V, f} = 1 \text{ MHz,}$	-	180	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	5	-	pF
Coss eq. (2)	Equivalent output capacitance	V _{GS} = 0, V _{DS} = 0 to 480 V	-	530	-	pF
Qg	Total gate charge	V _{DD} = 480 V, I _D = 35 A,	-	120	-	nC
Q_{gs}	Gate-source charge	V _{GS} = 10 V,	-	24	-	nC
Q_{gd}	Gate-drain charge	(see Figure 15)	-	52	-	nC
R _g	Gate input resistance	f = 1 MHz, gate DC Bias = 0, test signal level = 20 mV, I _D = 0	-	1.7	-	Ω

^{1.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

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^{2.} $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DS}

Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	30	-	ns
t _r	Rise time	$V_{DD} = 300 \text{ V}, I_{D} = 17.5 \text{ A}$ $R_{G} = 4.7 \Omega V_{GS} = 10 \text{ V}$	-	40	-	ns
t _{d(off)}	Turn-off delay time	(see Figure 14)	-	120	-	ns
t _f	Fall time		-	50	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current		-		35	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				140	Α
V _{SD} (2)	Forward on voltage I _{SD} = 35 A, V _{GS} = 0		-		1.3	V
t _{rr}	Reverse recovery time	I _{SD} = 35 A, di/dt = 100 A/μs	ı	190		ns
Q_{rr}	Reverse recovery charge	V _{DD} = 100 V		1.6		μC
I _{RRM}	Reverse recovery current	(see Figure 16)		17		Α
t _{rr}	Reverse recovery time	I _{SD} = 35 A, di/dt = 100 A/μs	ı	280		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 100 V, T _j = 150 °C	·	3.0		μC
I _{RRM}	Reverse recovery current	(see Figure 16)	·	22		Α

^{1.} Pulse width limited by safe operating area

^{2.} Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STW47NM60ND

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

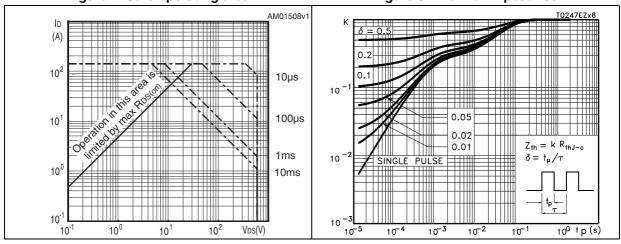


Figure 4. Output characteristics

Figure 5. Transfer characteristics

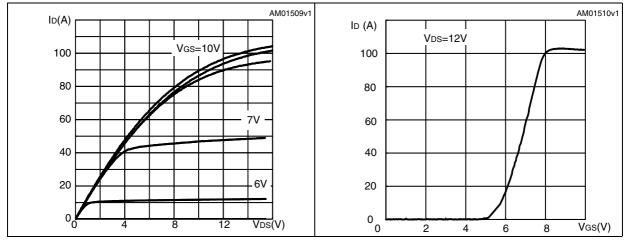
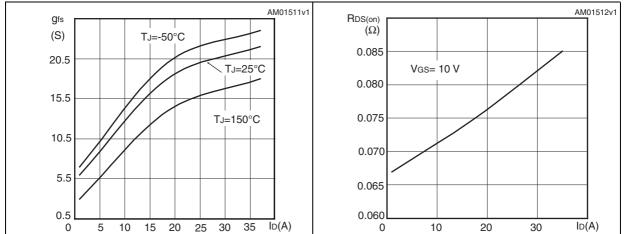


Figure 6. Transconductance

Figure 7. Static drain-source on-resistance



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Figure 8. Gate charge vs gate-source voltage

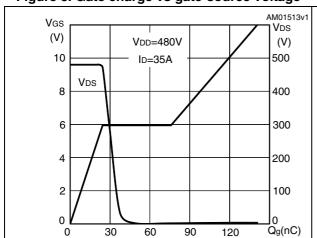


Figure 9. Capacitance variations

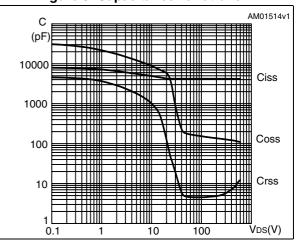
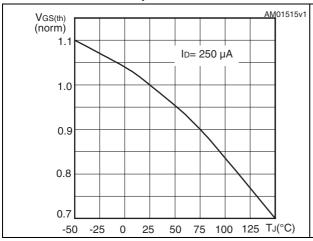


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on resistance vs temperature



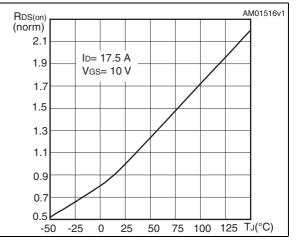
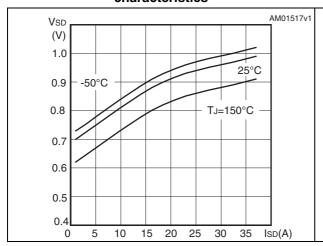
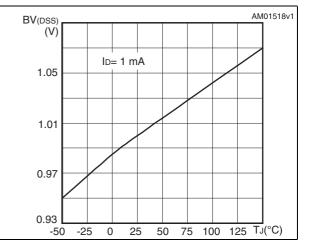


Figure 12. Source-drain diode forward characteristics

Figure 13. Normalized $\mathrm{BV}_{\mathrm{(DSS)}}$ vs temperature





Test circuits STW47NM60ND

3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

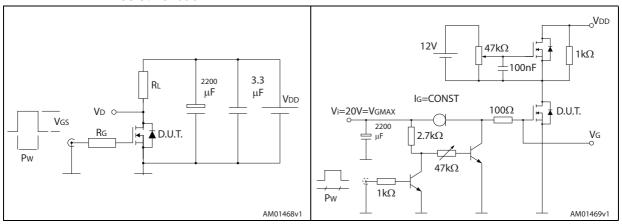


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

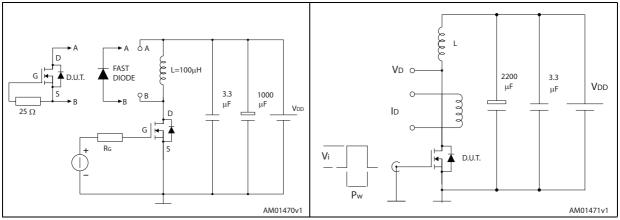
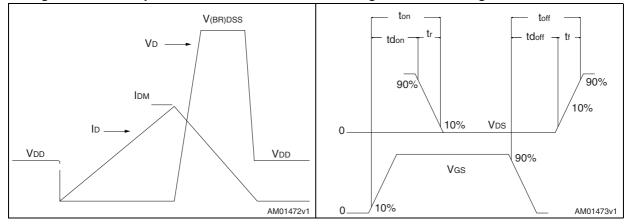


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



Table 9. TO-247 mechanical data

Dim.		mm.	
Dim.	Min.	Тур.	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

HEAT-SINK PLANE

A

BACK VIEW

0075325, G

Figure 20. TO-247 drawing

Revision history STW47NM60ND

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
26-Nov-2010	1	First release.
11-Feb-2011	2	Updated coverpage, Table 5 and Section 4.
30-Nov-2012	3	Updated: - Capacitances and gate charge values on Table 6 - Figure 4, Figure 5, Figure 7, Figure 8, Figure 9, Figure 10, Figure 11 and Figure 13 - Section 4: Package mechanical data Minor text changes on the cover page to improve readability.
22-Oct-2013	4	Updated title and features in cover pageMinor text changes

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